



SEMiX® 3s

Trench IGBT Modules

SEMiX303GB12E4s

Features

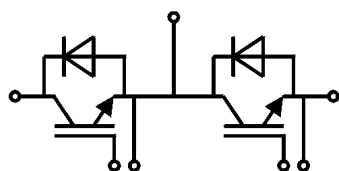
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- UL recognized, file no. E63532

Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Product reliability results are valid for $T_J=150^\circ\text{C}$
- Dynamic values apply to the following combination of resistors:
 $R_{Gon,main} = 1,0\ \Omega$
 $R_{Goff,main} = 1,0\ \Omega$
 $R_{G,X} = 2,0\ \Omega$
 $R_{E,X} = 0,5\ \Omega$



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Absolute Maximum Ratings

Symbol	Conditions	Values	Unit
IGBT			
V_{CES}	$T_J = 25^\circ\text{C}$	1200	V
I_C	$T_J = 175^\circ\text{C}$	$T_C = 25^\circ\text{C}$	466
		$T_C = 80^\circ\text{C}$	359
I_{Cnom}		300	A
I_{CRM}	$I_{CRM} = 3 \times I_{Cnom}$	900	A
V_{GES}		-20 ... 20	V
t_{psc}	$V_{CC} = 800\text{ V}$ $V_{GE} \leq 20\text{ V}$ $V_{CES} \leq 1200\text{ V}$	$T_J = 150^\circ\text{C}$	10
T_J		-40 ... 175	$^\circ\text{C}$
Inverse diode			
I_F	$T_J = 175^\circ\text{C}$	$T_C = 25^\circ\text{C}$	338
		$T_C = 80^\circ\text{C}$	252
I_{Fnom}		300	A
I_{FRM}	$I_{FRM} = 3 \times I_{Fnom}$	900	A
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_J = 25^\circ\text{C}$	1485	A
T_J		-40 ... 175	$^\circ\text{C}$
Module			
$I_{t(RMS)}$	$T_{terminal} = 80^\circ\text{C}$	600	A
T_{stg}		-40 ... 125	$^\circ\text{C}$
V_{isol}	AC sinus 50Hz, $t = 1\text{ min}$	4000	V

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 300\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_J = 25^\circ\text{C}$	1.8	2.05	V
		$T_J = 150^\circ\text{C}$	2.2	2.4	V
V_{CE0}	chipelevel	$T_J = 25^\circ\text{C}$	0.8	0.9	V
		$T_J = 150^\circ\text{C}$	0.7	0.8	V
r_{CE}	$V_{GE} = 15\text{ V}$ chipelevel	$T_J = 25^\circ\text{C}$	3.3	3.8	$\text{m}\Omega$
		$T_J = 150^\circ\text{C}$	5.0	5.3	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE}=V_{CE}, I_C = 11.4\text{ mA}$	5	5.8	6.5	V
I_{CES}	$V_{GE} = 0\text{ V}$ $V_{CE} = 1200\text{ V}$	$T_J = 25^\circ\text{C}$		4.0	mA
		$T_J = 150^\circ\text{C}$			mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	18.5		nF
C_{oes}		$f = 1\text{ MHz}$	1.22		nF
C_{res}		$f = 1\text{ MHz}$	1.03		nF
Q_G	$V_{GE} = -8\text{ V...} + 15\text{ V}$		1695		nC
R_{Gint}	$T_J = 25^\circ\text{C}$		2.50		Ω
$t_{d(on)}$	$V_{CC} = 600\text{ V}$	$T_J = 150^\circ\text{C}$	255		ns
t_r	$I_C = 300\text{ A}$	$T_J = 150^\circ\text{C}$	57		ns
E_{on}	$V_{GE} = \pm 15\text{ V}$ $R_{Gon} = 1.9\ \Omega$	$T_J = 150^\circ\text{C}$	30		mJ
$t_{d(off)}$	$R_{Goff} = 1.9\ \Omega$	$T_J = 150^\circ\text{C}$	565		ns
t_f	$di/dt_{on} = 5250\text{ A}/\mu\text{s}$ $di/dt_{off} = 2825\text{ A}/\mu\text{s}$	$T_J = 150^\circ\text{C}$	98		ns
E_{off}		$T_J = 150^\circ\text{C}$	41.2		mJ
$R_{th(j-c)}$	per IGBT			0.095	K/W



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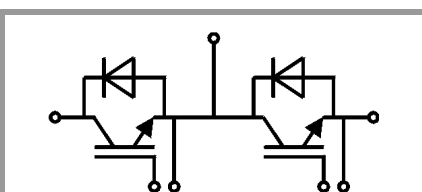
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Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
Inverse diode						
V _F = V _{EC}	I _F = 300 A	T _j = 25 °C		2.2	2.52	V
	V _{GE} = 0 V chipelevel	T _j = 150 °C		2.2	2.5	V
V _{F0}	chipelevel	T _j = 25 °C	1.1	1.3	1.5	V
		T _j = 150 °C	0.7	0.9	1.1	V
r _F	chipelevel	T _j = 25 °C	2.7	3.0	3.4	mΩ
		T _j = 150 °C	3.5	4.2	4.6	mΩ
I _{RRM}	I _F = 300 A	T _j = 150 °C		300		A
Q _{rr}	di/dt _{off} = 5100 A/μs	T _j = 150 °C		44.2		μC
E _{rr}	V _{GE} = -15 V V _{CC} = 600 V	T _j = 150 °C		17.7		mJ
R _{th(j-c)}	per diode				0.18	K/W
Module						
L _{CE}				20		nH
R _{CC'+EE'}	res., terminal-chip	T _C = 25 °C		0.7		mΩ
		T _C = 125 °C		1		mΩ
R _{th(c-s)}	per module			0.04		K/W
M _s	to heat sink (M5)		3		5	Nm
M _t		to terminals (M6)	2.5		5	Nm
						Nm
w					300	g
Temperature Sensor						
R ₁₀₀	T _c =100°C (R ₂₅ =5 kΩ)			493 ± 5%		Ω
B _{100/125}	R(T)=R ₁₀₀ exp[B _{100/125} (1/T-1/T ₁₀₀)]; T[K];			3550 ±2%		K



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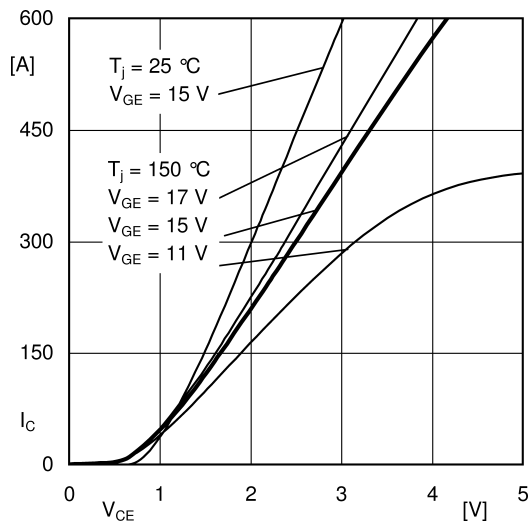


Fig. 1: Typ. output characteristic, inclusive $R_{CC'} + E_{E'}$

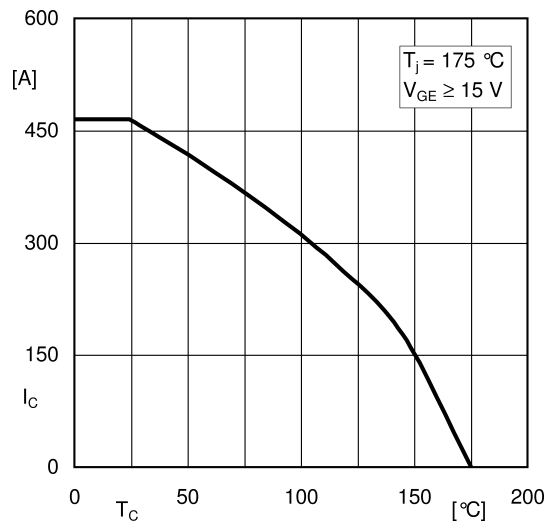


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

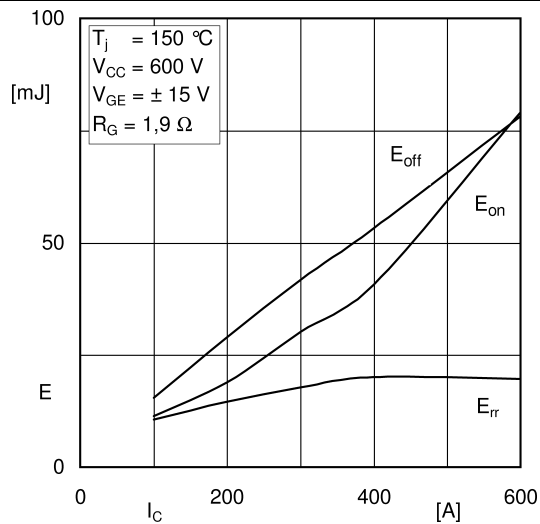


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

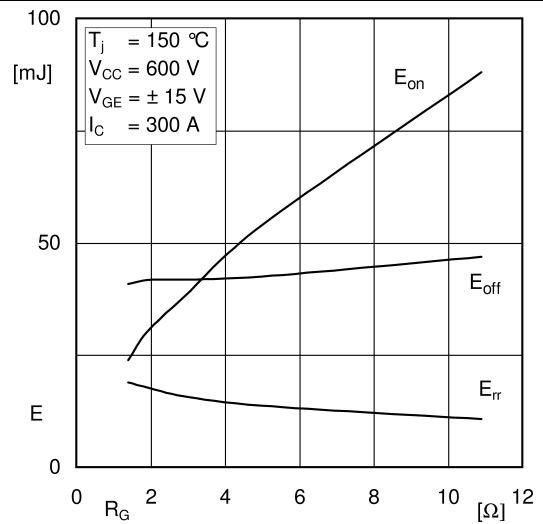


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

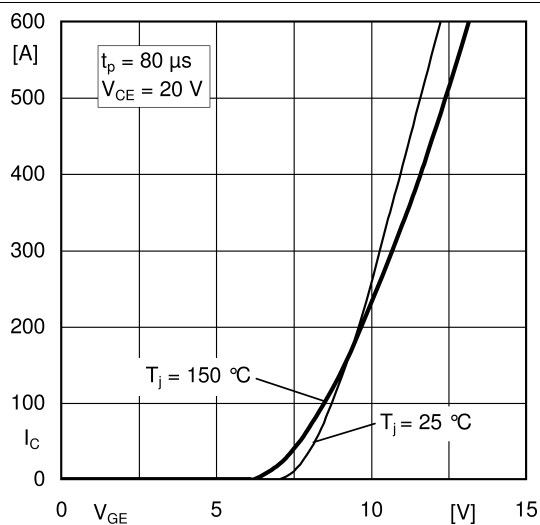


Fig. 5: Typ. transfer characteristic

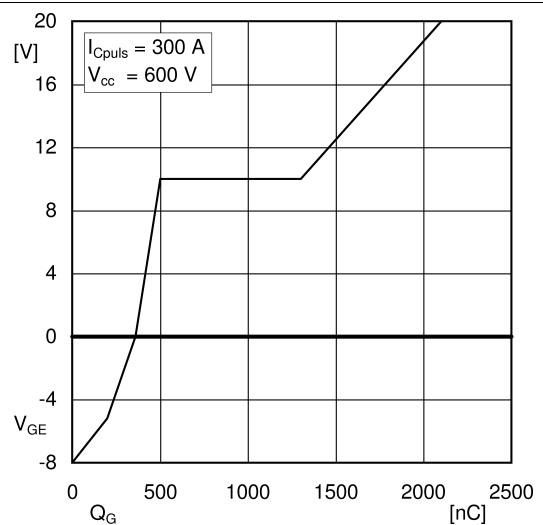


Fig. 6: Typ. gate charge characteristic

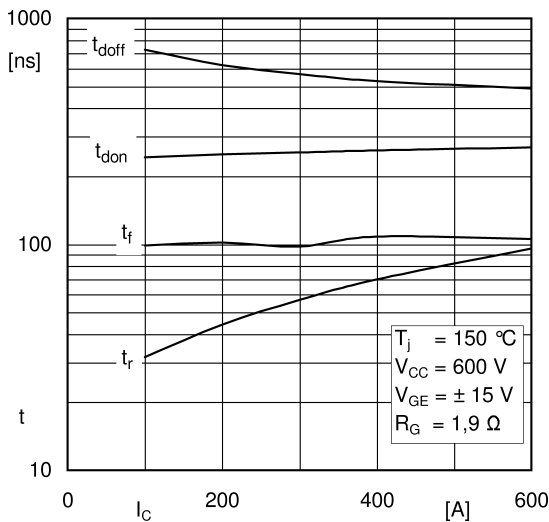


Fig. 7: Typ. switching times vs. I_C

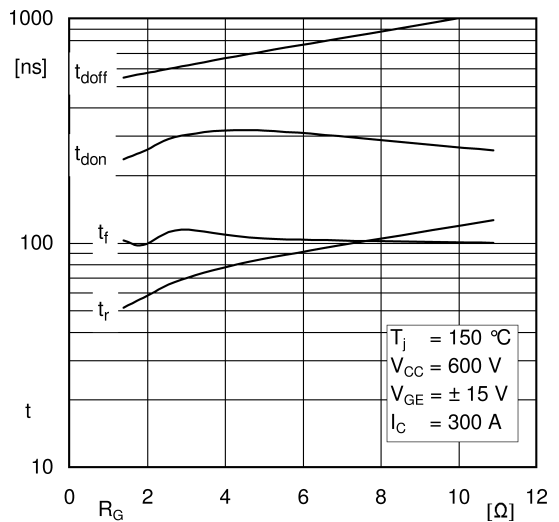


Fig. 8: Typ. switching times vs. gate resistor R_G

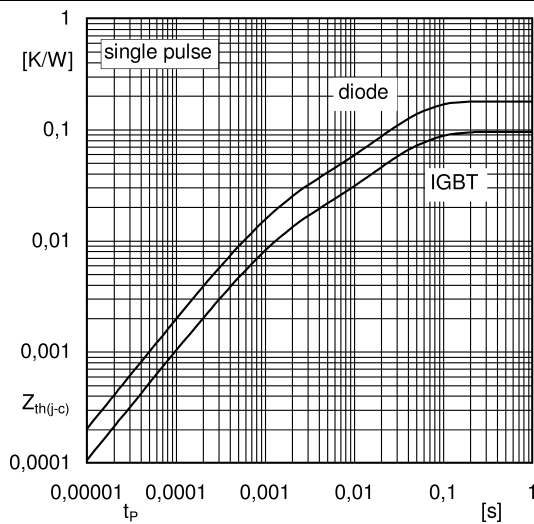


Fig. 9: Typ. transient thermal impedance

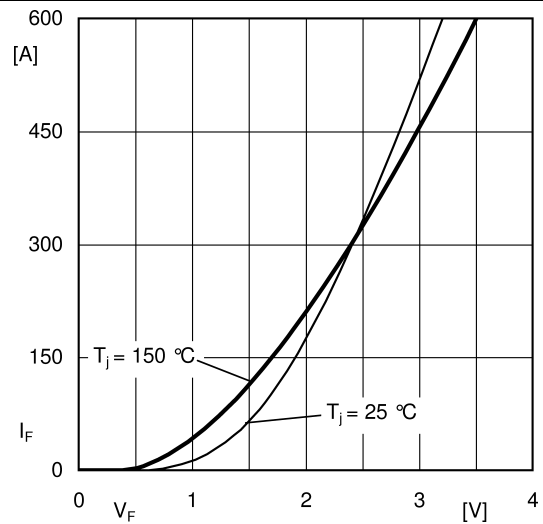


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'}+EE'$

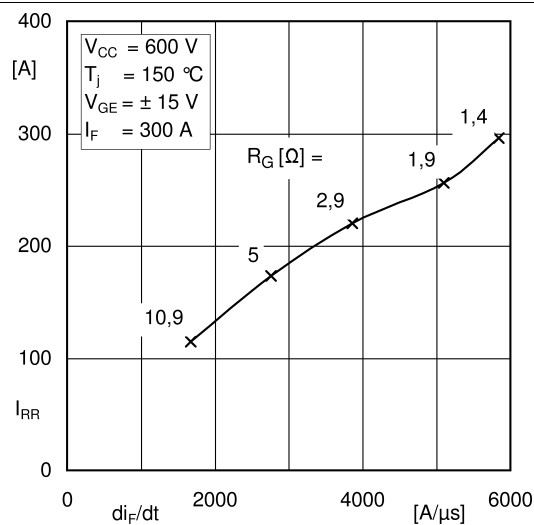


Fig. 11: Typ. CAL diode peak reverse recovery current

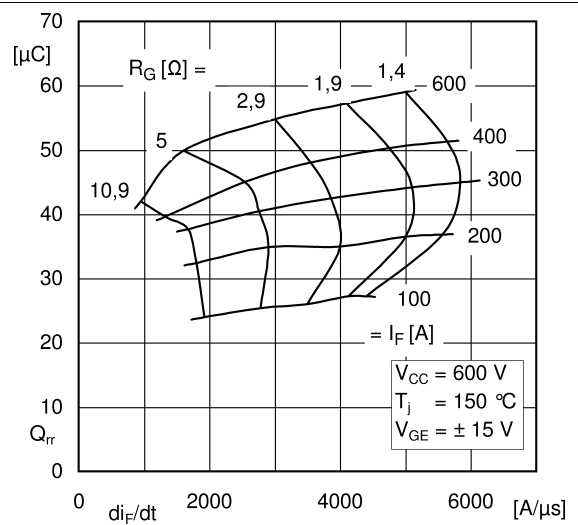


Fig. 12: Typ. CAL diode recovery charge

